Short Communication

Synthesis and some properties of trifluoro(trifluoromethyl)silane

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The simplest perfluoroalkylfluorosilane, CF_3SiF_3 , has remained essentially uncharacterized up to the present. Although a patent¹ claims synthesis from the passage of CF_3Br or C_2F_5Br over Si-Cu alloy at 400-500°, other workers have indicated that the preparation involves very low yields, or have not reported the compound from the same or closely similar reactions under comparable conditions^{2-4†}. Moreover, from what is now known of the thermal stability of this class of compounds, it seems highly unlikely that CF_3SiF_3 could persist in appreciable quantities at such temperatures^{4, 5}.

The development of synthetic techniques based on the low-temperature reactions of the high-temperature molecule silicon diffuoride has greatly expanded the potential for syntheses of perfluoro(alkylsilanes) in which the stringent conditions involved in the "direct" reactions are avoided. Thus, utilizing the recently reported⁶ diffuoroiodo(triffuoromethyl)silane, we have obtained CF₃SiF₃ (I) in high yields, and determined several of its salient properties.

CF₃SiF₂I was prepared from the low-temperature reaction⁶ of SiF₂ with CF₃I, and was purified on a low-temperature distillation column. Reaction of gaseous CF₃SiF₂I with SbF₃, AsF₃, or AgF occurs very rapidly at 25°, and, in the case of SbF₃, proceeds at temperatures at least as low as -55° . In a typical run, 71.2 mg of CF₃SiF₂I was condensed into a bulb containing an excess of SbF₃, and the bulb contents shaken as they warmed to room temperature. The iodide was found to be completely reacted to give 36.6 mg of (I) (88%), the decomposition products C₂F₄ and SiF₄, and a small amount (*ca.* 1%) of the hydrolysis product CF₃H. Compound (I) was separated from the more volatile impurities on the low-temperature column. SiF₄, C₂F₄, and CF₃H distil from the column at -160° (5 × 10⁻⁵ torr); compound (I) distils in the range -156 to -149° .

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[†] Dr. F. E. Brinckman, of this laboratory, has attempted to duplicate the synthesis described in Reference 1 with the following results: No carbon- or bromine-containing volatile products except unreacted CF_3Br were observed; silicon was recovered as the mixed fluorochloromonosilanes. The source of the chlorine is the cuprous chloride used to prepare the Si-Cu alloy. (Private communication.)

The ¹⁹F NMR spectrum of (I) in a 50% solution in CF₃I consists of two identical quartets [J(F-F) = 10.9 Hz] at 66.3 $[CF_3]$ and 150.7 $[SiF_3]$ ppm*. From the ²⁹Si satellite spectra, J(Si-F) = 273.2 Hz and J(Si-C-F) = 72.2 Hz. The magnitude of the Si-F coupling constant for the directly-bonded nuclei is larger than might be anticipated from the relationship of J(Si-F) and substituent electronegativities for SiF₃X compounds; it is quite close to that observed (267.2 Hz) in CH₃SiF₃⁷.

The mass spectrum of (I) was obtained using a 180 degree sector, magnetic deflection instrument and was found to be related to those of $Si_2F_6^8$ and $C_2F_6^9$, in that the molecular ion $CSiF_6^+$ is of negligible intensity at electron voltages down to at least 17 eV. The most intense ion at 70 eV is $CSiF_5^+$, followed by SiF_3^+ , CF^+ , CF_2^+ , CF_3^+ , SiF_2^+ , $CSiF_4^+$ (very small). The placement of SiF_3^+ and CF_2^+ in the preceding sequence is somewhat uncertain because of the presence of SiF_4 and C_2F_4 as thermal decomposition products in the ion source of the mass spectrometer. At 17 eV, the CF_2^+ ion is at least an order of magnitude more intense than any other.

The infrared spectrum of (I) from 2000–200 cm⁻¹ has been determined. Frequencies and relative intensities are as follows: 1251 (w), 1133 (vs), 1023 (s), 866 (m), 730 (vw), 520 (vw), 495 (m), 354 (m), 261 (w). By analogy with C_2F_6 , Si₂F₆, and other molecules containing a CF₃ or SiF₃ function, one may assign the two highest frequency bands to antisymmetric and symmetric C-F stretching vibrations, respectively; the next two bands to antisymmetric and symmetric Si-F stretches. The two strongest remaining absorptions, at 495 and 354 cm⁻¹, are most probably due to CF₃ and SiF₃ deformations.

A preliminary investigation of the microwave spectrum of (I) has been undertaken. Results to date are completely consistent with the assignment of CF_3SiF_3 as the structure of (I)¹⁰.

The molecular weight of (I) was determined by the Dumas method (calcd., 154.1; found, 154.6).

Basic hydrolysis of (I) with excess aqueous NaOH yields CF_3H as the only volatile product. Vapor phase hydrolysis with a deficiency of water vapor gives CF_3H and SiF_4 , but no volatile oxygen-containing species.

The thermal stability of (I) is of interest in view of the results of other workers on highly halogenated organosilanes:

$$\operatorname{CCl}_{3}\operatorname{SiF}_{3} \xrightarrow{140^{\circ}-180^{\circ}} :\operatorname{CCl}_{2} + \operatorname{SiF}_{3}\operatorname{Cl}$$
(Ref. 11)

$$CF_2HCF_2SiF_3 \longrightarrow CF_2HCF + SiF_4$$
 (Ref. 12)

Quantitative decomposition of (I) is observed at temperatures as low as 78° (17 h), and decomposition proceeds rapidly at temperatures above 100° . In all

^{*} Reported relative to external CFCl₃, using the relationship δ (CF₃I-CFCl₃) = 4.78 ppm.

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instances the products are SiF₄, C₂F₄, and cyclo-C₃F₆. The typical amount of C₂F₄ recovered represents 90% of the carbon-containing products. If one makes the reasonable assumption that CF₂ is the source of C₂F₄, the pyrolysis of (1) apparently represents the most labile vapor phase thermal source of CF₂ yet reported. Investigations of the reaction chemistry of (I), both as a source of difluorocarbene and as a derivative of SiF₄, are currently underway. Other work in progress includes synthesis of C₂F₅SiF₃ from its iodosilane analog.

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